

EMC Seminar Series
All about EMC Testing and Measurement Seminar – 2
 organized by
Electromagnetic Compatibility Hong Kong Chapter, IEEE

This seminar is the second in a series of tutorials in the fundamental EMC principles, testing and measurements providing the basic technical information of EMC measurements that would be essential when testing in an EMC test laboratory. The seminar will include the rationale of why such measurement, how to do it, and what is the governing standards and regulations for such measurement. The second seminar will cover the following topics:

1. [EMC Conducted Emission](#)
2. [EMC Immunity: Electro-Static Discharge \(ESD\)](#)
3. [EMC Immunity: Electric Fast Transient \(EFT\)](#)

All speakers are IEEE EMC Chapter committee members who are all very experienced in the field of EMC. This first seminar shall provide a very good insight into various aspects in EMC testing and measurements for engineers who are required to be in touch with EMC product testing.

Venue:	LT 401 ,4/F, Amenities Building, City University of Hong Kong http://www6.cityu.edu.hk/wayfinder/tc/Venue/LT401
Date & Time:	18 th April 2015 (Saturday), 9:40am – 12:15am
No. of Attendance:	Limited to a maximum number of 80 <i>Pre-registration is required</i>
Fee:	Free of Charge

Schedule

9:40am	<i>Registration</i>
10:00 - 10:30 am	EMC Conducted Emission <i>By Dr. Duncan L. F. Fung, Hong Kong Accreditation Service</i>
10:30 – 11:00 am	EMC Immunity: Electro-Static Discharge (ESD) <i>By Dr. Brian K. H. Chan, Hong Kong Productivity Council</i>
<i>~ Coffee break ~</i>	
11:20 – 12:00 am	EMC Immunity: Electric Fast Transient (EFT) <i>By Mr. L. Wai, Hong Kong Productivity Council</i>
12:00 – 12:15pm	<i>~ Q & A ~</i>

Enquiries and Reservation:

Interested parties, please send your name, company name, contact number, email, and IEEE membership no. (if any) to the below contact for seat reservation.

Mr. George Chan, Secretary of IEEE EMC Hong Kong Chapter - e-mail: ieeekemc@gmail.com